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## Dual N-Channel PowerTrench<sup>®</sup> MOSFET Q1: 30 V, 22 A, 10.0 m $\Omega$ Q2: 30 V, 30 A, 6.3 m $\Omega$

### Features

### Q1: N-Channel

- Max  $r_{DS(on)}$  = 10.0 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 12 A
- Max  $r_{DS(on)}$  = 13.6 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 10 A

### Q2: N-Channel

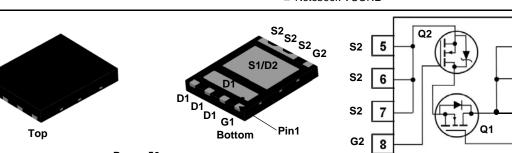
- Max  $r_{DS(on)}$  = 6.3 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 15 A
- Max  $r_{DS(on)}$  = 7.2 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 13 A
- RoHS Compliant

### **General Description**

This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET<sup>TM</sup> (Q2) have been designed to provide optimal power efficiency.

### Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE





### MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V <sub>DS</sub>	Drain to Source Voltage		30	30	V	
V <sub>GS</sub>	Gate to Source Voltage	(Note 3)	±20	±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C	22	30		
I <sub>D</sub>	-Continuous	T <sub>A</sub> = 25 °C	12 <sup>1a</sup>	15 <sup>1b</sup>	Α	
	-Pulsed		50	60		
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 4)	29	33	mJ	
D	Power Dissipation for Single Operation	T <sub>A</sub> = 25°C	2.2 <sup>1a</sup>	2.5 <sup>1b</sup>	14/	
P <sub>D</sub>	Power Dissipation for Single Operation	T <sub>A</sub> = 25°C	1.0 <sup>1c</sup>	1.0 <sup>1d</sup>	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to	+150	°C	

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		50 <sup>1b</sup>	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	125 <sup>1c</sup>	120 <sup>1d</sup>	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	4.0	3.2	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7608S	FDMS7608S	Power 56	13 "	12 mm	3000 units

May 2014

4 D1

3

2

1

D1

D1

G1

FDMS7608S D
Dual N-Channel F
PowerTrench <sup>®</sup>
MOSFET

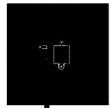
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, V_{GS} = 0 \ V$ $I_D = 1 \ mA, V_{GS} = 0 \ V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$ , referenced to 25°C $I_D = 10 mA$ , referenced to 25°C	Q1 Q2		13 19		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V	Q1 Q2			1 500	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = 20$ V, $V_{DS} = 0$ V	Q1 Q2			100 100	nA nA
On Chara	acteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$ $V_{GS} = V_{DS}$ , $I_D = 1 \ mA$	Q1 Q2	1.2 1.2	1.9 1.7	3.0 3.0	V
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25°C $I_D = 10 \ m$ A, referenced to 25°C	Q1 Q2		-6 -4		mV/°C
r	Static Drain to Source On Resistance		Q1		7.4 10.0 10.3	10.0 13.6 13.9	- mΩ
r <sub>DS(on)</sub>			Q2		4.8 6.0 6.6	6.3 7.2 8.6	
9 <sub>FS</sub>	Forward Transconductance	$V_{DD} = 5 V, I_D = 12 A$ $V_{DD} = 5 V, I_D = 15 A$	Q1 Q2		54 76		S
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance	Q1: $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$ Q2: $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2		1135 1380	1510 1835	pF
C <sub>oss</sub>	Output Capacitance		Q1 Q2		390 478	520 635	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q1 Q2		42 60	65 90	pF
R <sub>g</sub>	Gate Resistance		Q1 Q2	0.2 0.2	1.6 0.5	3.2 2.0	Ω
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	Q1	Q1 Q2		7 7	14 14	ns
t <sub>r</sub>	Rise Time	$V_{DD}$ = 15 V, $I_D$ = 12 A, $R_{GEN}$ = 6 $\Omega$	Q1 Q2		3 3	10 10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2 V <sub>DD</sub> = 15 V, I <sub>D</sub> = 15 A, R <sub>GEN</sub> = 6 Ω	Q1 Q2		19 20	35 36	ns
t <sub>f</sub>	Fall Time		Q1 Q2		3 2	10 10	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{GS} = 0V$ to 10 V Q1 V <sub>DD</sub> = 15 V,	Q1 Q2		18 21	24 30	nC
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{GS} = 0V \text{ to } 5 \text{ V}$ $I_D = 12 \text{ A}$	Q1 Q2		9 12	14 16	nC
Q <sub>gs</sub>	Gate to Source Charge	Q2	Q1 Q2		3.6 3.5		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 15 A	Q1 Q2		2.5 3.0		nC

2

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-Sou	urce Diode Characteristics							
V <sub>SD</sub>	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 2 A$	(Note 2)	Q1		0.75	1.1	V
		$V_{GS} = 0 V, I_{S} = 12 A$	(Note 2)	Q1		0.84	1.2	
		$V_{GS} = 0 V, I_{S} = 2 A$	(Note 2)	Q2		0.63	0.8	
		$V_{GS} = 0 V, I_{S} = 15 A$	(Note 2)	Q2		0.80	1.2	
t <sub>rr</sub> Reverse R		Q1		Q1		25	40	
	Reverse Recovery Time	$I_{\rm F} = 12$ A, di/dt = 100 A/µs		Q2		21	34	ns
Q <sub>rr</sub>	Reverse Recovery Charge	Q2		Q1		9	18	_
		$I_{F} = 15 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$		Q2		19	33	nC

Notes:

TR<sub>0LA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{BJC}$  is guaranteed by design while  $R_{BCA}$  is determined by the user's board design.







c. 125 °C/W when mounted on a minimum pad of 2 oz copper

a. 57 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



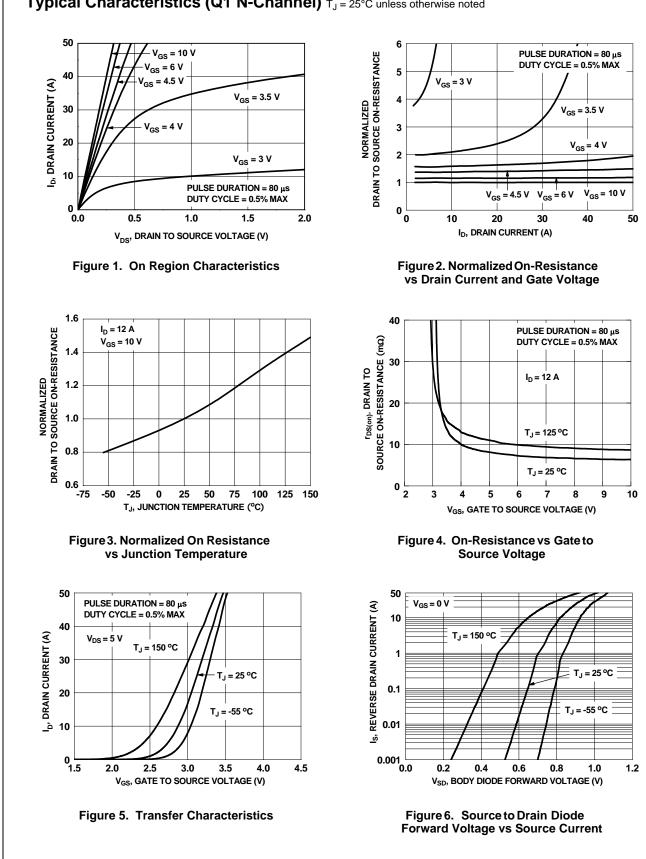
 d. 120 °C/W when mounted on a minimum pad of 2 oz copper

b. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

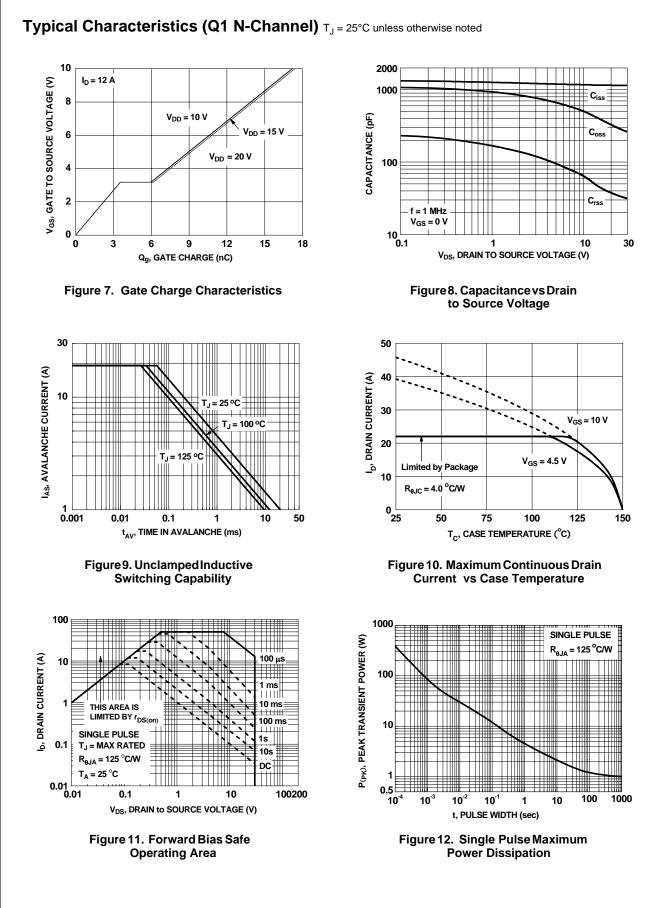
3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

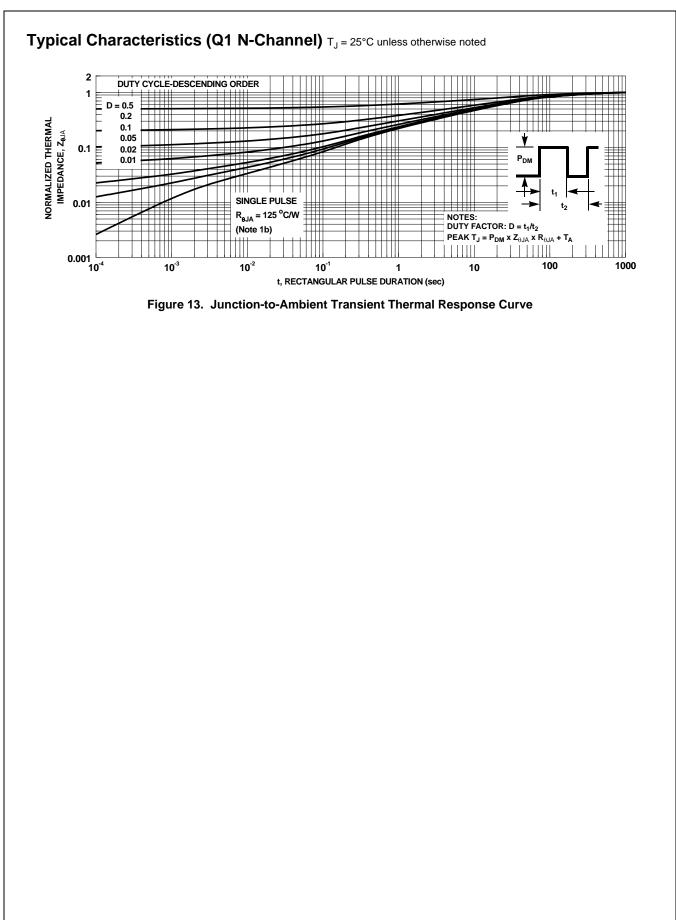
4. Q1:  $E_{AS}$  of 29 mJ is based on starting  $T_J$  = 25 °C; N-ch: L = 0.3 mH,  $I_{AS}$  = 14 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% tested at L = 3 mH,  $I_{AS}$  = 3.75 A. Q2:  $E_{AS}$  of 33 mJ is based on starting  $T_J$  = 25 °C; N-ch: L = 0.3 mH,  $I_{AS}$  = 15 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% tested at L = 3 mH,  $I_{AS}$  = 3.9 A.

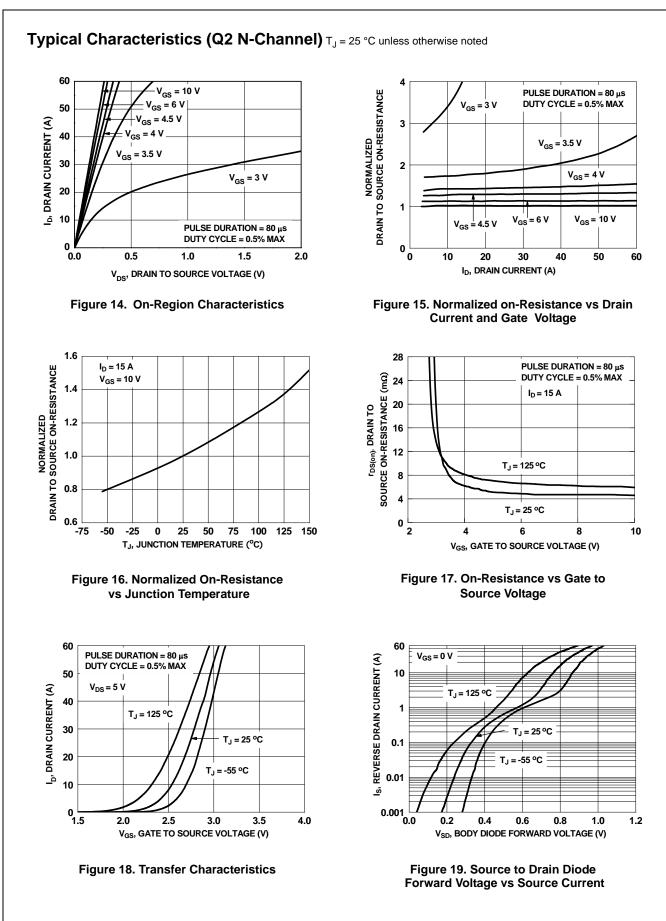


### Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted

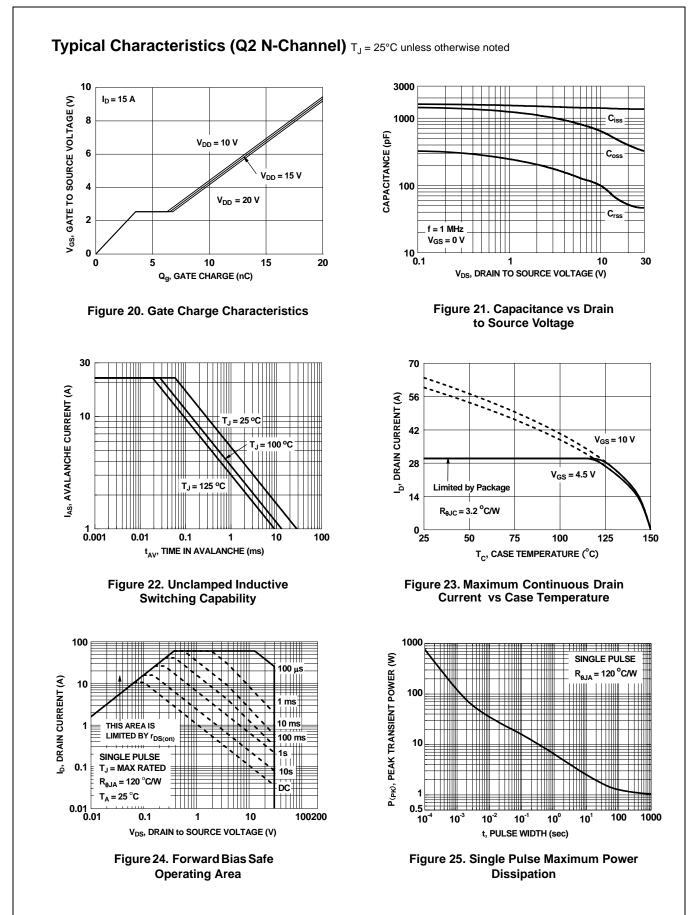






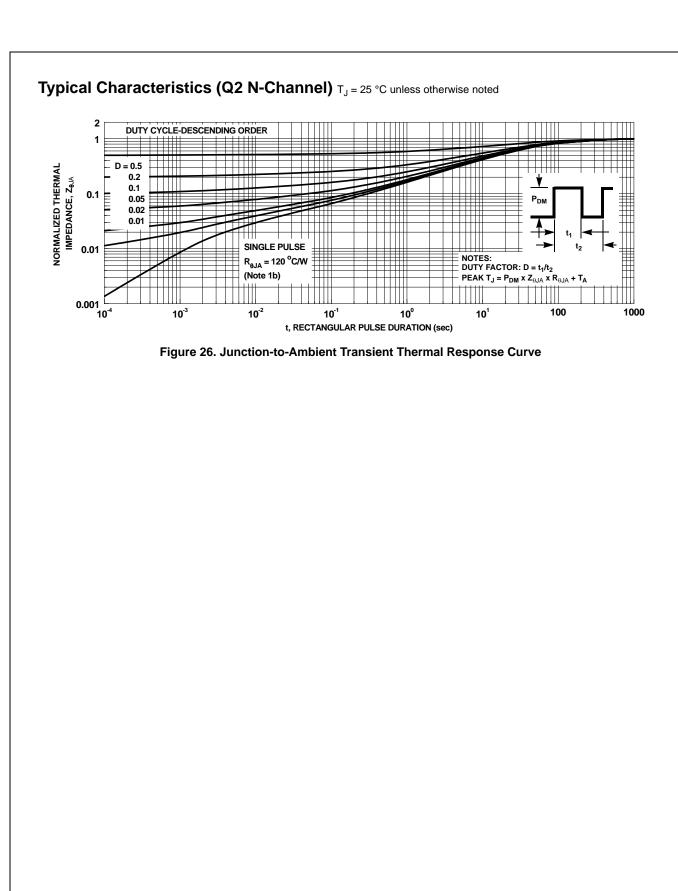






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# FDMS7608S Dual N-Channel PowerTrench<sup>®</sup> MOSFET

### Typical Characteristics (continued)

### SyncFET<sup>™</sup> Schottky body diode Characteristics

Fairchild's SyncFET<sup>TM</sup> process embeds a Schottky diode in parallel with PowerTrench<sup>®</sup> MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS7608S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

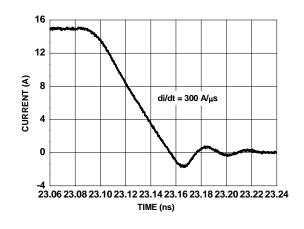


Figure 27. FDMS7608S SyncFET<sup>™</sup> Body Diode Reverse Recovery Characteristic

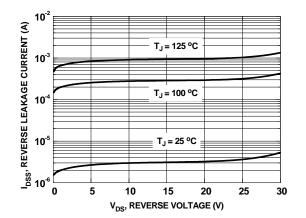
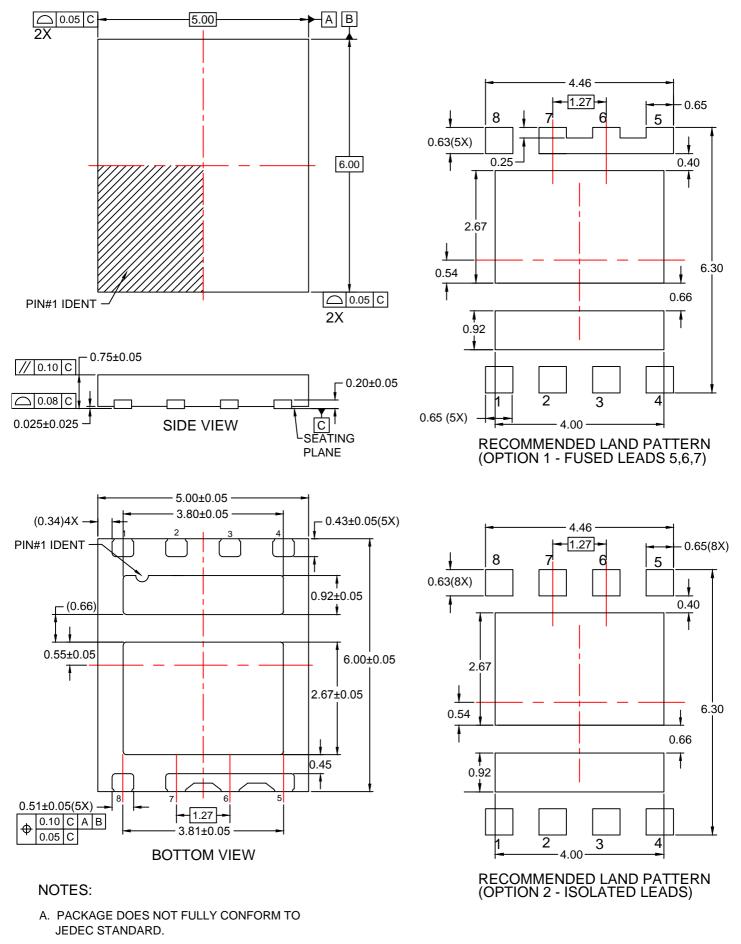


Figure 28. SyncFET<sup>™</sup> Body Diode Reverse Leakage vs. Drain-Source Voltage



- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Prev2.



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